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| INFORMATION DISCLOSED CITATION (Use several sheets if necessary) | | | | Docket Number (Optional) | Application Number |
| | | | | Applicant(s) Larry Hryshko | |
| | | | | Filing Date | 10/530868 - GAU |
| | | | | SEARCHER UNIT 1657 | |

U.S. PATENT DOCUMENTS

| *EXAMINER INITIAL | REF | DOCUMENT NUMBER | DATE | NAME | CLASS | SUBCLASS | FILING DATE IF APPROPRIATE |
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U.S. PATENT APPLICATION PUBLICATIONS

| *EXAMINER INITIAL | REF | DOCUMENT NUMBER | DATE | NAME | CLASS | SUBCLASS | FILING DATE IF APPROPRIATE |
|-------------------|-----|-----------------|-----------|--------------------|-------|----------|----------------------------|
| /A.W./ | | 2002/064841 | May 30/02 | Mark A Reed et al. | | | |
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FOREIGN PATENT DOCUMENTS

| | REF | DOCUMENT NUMBER | DATE | COUNTRY | CLASS | SUBCLASS | Translation | |
|--------|-----|-----------------|------------|---------|-------|----------|-------------|----|
| | | | | | | | YES | NO |
| /A.W./ | | 02/29402 | Apr. 11/02 | WO | | | | |
| /A.W./ | | 01/94939 | Dec. 13/01 | WO | | | | |
| /A.W./ | | 01/48475 | July 5/01 | WO | | | | |
| /A.W./ | | 02/64253 | Aug 22/02 | WO | | | | |
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OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

| | | | | | | | |
|--------|--|--|--|--|--|--|--|
| /A.W./ | | Mosbacher J et al, "Studying Membranes With Scanning Force Microscopy and Patch-Clamp Technique", Journal of Vacuum Science and Technology: Part B, American Institute of Physics, vol. 14, no. 2, March 1, 1996, pages 1449-1452. | | | | | |
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| EXAMINER /Amanda Wood/ | DATE CONSIDERED 9/2008 |
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EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP Section 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.